Avalanche Photodiodes

AVALANCHE PHOTODIODES

Avalanche Photodiodes 1060 nm NIR Enhanced Si APDs



1064 nm NIR Enhanced Si APDs

Applications

- Range finding
- LiDAR (Light Detection And Ranging)
- YAG laser detection

Features and Benefits

- High quantum efficiency at 1060 nm
- Fast response time
- Wide operating temperature range
- Low capacitance
- Hermetically-sealed packages
- RoHS compliant
- Customization available upon request

Spectral Responsivity Characteristics 80 400 500 600 700 800 900 1000 1100 1200 Wavelength [nm] — C30954EH — — C30955EH — — C30956EH

*Note: Package dimensions for indication only. Exact package dimensions can be found on products datasheets

Product Description

The C30954EH, C30955EH, and C30956EH are general purpose silicon avalanche photodiodes made using a double-diffused "reach-through" structure. The APD design is optimized for 1064nm operation.

These APDs have quantum efficiency of up to 40% at 1064 nm. At the same time, the diodesretain the low noise, low capacitance, and fast rise and fall times characteristics.

To help simplify many design needs, these APDs are also available in Excelitas' high-performance hybrid preamplifier module type C30659 series, as well as the preamplifier and TE cooler incorporated module type LLAM series. In addition, these APDs are also available with built-in thermo-electric cooler for easier temperature control. Please refer to the respective sections in this catalog.

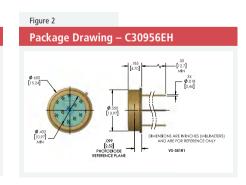
Product Table

Si APDs - NIR Enha

SI AI D3 WIN Elimanced												
Part Number	Photo Sensitive Diameter	Typical Responsivity @ 1060 nm	Typical Dark Current	Spectral Noise Current	Capacitance @ 100 KHz	Response Time	NEP@ 1060 nm	Vop Range				
Unit	mm	A/W	nA	pA/√Hz	pF	ns	fW/√Hz	V				
C30954EH	0.8	36	50	1.0	2	2	28	300 - 475				
C30955EH	1.5	34	100	1.0	3	2	29	315 - 490				
С30956ЕН	3.0	25	100	1.1	10	2	44	325 - 500				

TC stands for single stage cooler, operating temperature 0° C DTC stands for double stage cooler, operating temperature -20° C

Package Drawing – C30954EH, C30955EH



Product Table

Silicon APD – TE-Cooled

	Active Diameter	Active Area	Total Capacitance	Rise/Fall Time	Dark Current	Breakdown Voltage min	Breakdown Voltage max	Temperature Coefficient	Typical Gain	830 nm ´	900 nm	Responsivity 1060 nm	Current	
Unit	mm	mm²	pF	ns	nA	V	V	***************************************		A/W	A/W	A/W	pA/√Hz	Package
C30954EH-TC	0.8	0.5	2	2	8	300	475	2.4	120	-	75	36	0.2	TO-8 flange
C30955EH-TC	1.5	1.8	3	2	15	315	490	2.4	100	-	70	34	0.2	TO-8 flange
C30956EH-TC	3	7	10	2	15	325	500	2.4	75	-	45	25	0.2	TO-8 flange

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